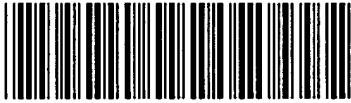


Search Notes

Application/Control No.

10/540,238

Examiner

Helen C. Kwok

Applicant(s)/Patent under
Reexamination

MIKADO ET AL.

Art Unit

2856

SEARCHED

Class	Subclass	Date	Examiner
73	514.34	4/26/2006	HK
73	514.29	4/26/2006	HK
73	514.16	4/26/2006	HK
73	514.33	4/26/2006	HK
310	329-332	4/26/2006	HK
310	311	4/26/2006	HK

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR